

## **General Description**

The WSR58P06 is the highest performance trench P-Ch MOSFET with extreme high cell density,which provide excellent  $R_{\text{DSON}}$  and gate charge for most of the synchronous buck converter applications .

The WSR58P06 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

#### **Features**

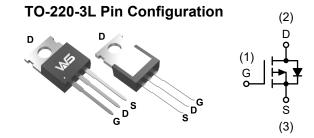
- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

### **Product Summery**

| BV <sub>DSS</sub> | R <sub>DSON</sub> | I <sub>D</sub> |
|-------------------|-------------------|----------------|
| -60V              | 30mΩ              | -45A           |

## **Applications**

 Power Management in Desktop Computer or DC/ DC Converters



# **Absolute Maximum Ratings**

| Symbol           | Parameter  | Rating     | Units      |
|------------------|--|------------|------------|
| $V_{DS}$         | Drain-Source Voltage   | -60        | V          |
| $V_{GS}$         | Gate-Source Voltage  | ±25        | V          |
| Ip               | Continuous Drain Current, V <sub>GS</sub> @ -10V;T <sub>C</sub> =25°C  | -45        | Α          |
| טו               | Continuous Drain Current, V <sub>GS</sub> @ -10V;T <sub>C</sub> =100°C | -25        | Α          |
| ls               | Diode Continuous Forward Current                                       | -45        | Α          |
| I <sub>AS</sub>  | Avalanche Energy, Single pulse ;L=1mH                                  | -18        | Α          |
| E <sub>AS</sub>  | Avalanche Energy, Single pulse;;L=1mH                                  | 81         | mJ         |
| I <sub>DP</sub>  | Pulse Drain Current Tested ;Tc=25°C                                    | -80        | Α          |
| P <sub>D</sub>   | Maximum Power Dissipation;T <sub>C</sub> =25°C                         | 54         | W          |
| FD               | Maximum Power Dissipation;T <sub>C</sub> =100°C                        | 21         | W          |
| T <sub>STG</sub> | Storage Temperature Range  | -55 to 150 | °C         |
| TJ               | Operating Junction Temperature Range                                   | -55 to 150 | $^{\circ}$ |

### **Thermal Data**

| Symbol            | Parameter   | Тур.                  | Max. | Unit |
|-------------------|---|-----------------------|------|------|
| $R_{	heta JA}$    | Thermal Resistance Junction-Ambient <sup>1</sup>          |                       | 62.5 | °C/W |
| $R_{\theta JA}$   | Thermal Resistance Junction-Ambient <sup>1</sup> (t ≤10s) | on-Ambient ¹ (t ≤10s) |      |      |
| R <sub>0</sub> JC | Thermal Resistance Junction-Case <sup>1</sup>             |                       | 2.3  | °C/W |

Note: \*Current limited by bond wire.

Note a : UIS tested and pulse width limited by maximum junction temperature 150  $^{\circ}$ C (initial temperature Tj=25  $^{\circ}$ C).



## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

| Symbol                               | Parameter                                      | Conditions  | Min. | Тур.   | Max. | Unit |  |
|--------------------------------------|--|---|------|--------|------|------|--|
| BV <sub>DSS</sub>                    | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA                          | -60  |        |      | V    |  |
| $\triangle BV_{DSS}/\triangle T_{J}$ | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25℃, I <sub>D</sub> =-1mA                                |      | -0.018 |      | V/°C |  |
| В                                    | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =-10V , I <sub>D</sub> =-10A                          |      | 30     | 47   |      |  |
| R <sub>DS(ON)</sub>                  | Static Drain-Source On-Resistance              | V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-5A                          |      | 42     | 58   | mΩ   |  |
| $V_{GS(th)}$                         | Gate Threshold Voltage                         | V <sub>GS</sub> =V <sub>DS</sub> . I <sub>D</sub> =-250uA             | -1.4 | -2.2   | -3.5 | ٧    |  |
| $\triangle V_{GS(th)}$               | V <sub>GS(th)</sub> Temperature Coefficient    | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250UA             |      | 5.04   |      | mV/℃ |  |
|                                      | Drain Source Loakage Current                   | V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃     |      |        | 1    |      |  |
| I <sub>DSS</sub>                     | Drain-Source Leakage Current                   | V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃     |      |        | 5    | uA   |  |
| I <sub>GSS</sub>                     | Gate-Source Leakage Current                    | $V_{GS}$ = $\pm 25V$ , $V_{DS}$ = $0V$                                |      |        | ±100 | nA   |  |
| gfs                                  | Forward Transconductance                       | $V_{DS}$ =-5V , $I_D$ =-2A  |      | 18     |      | S    |  |
| $Q_g$                                | Total Gate Charge (-4.5V)                      |   |      | 24     |      |      |  |
| $Q_gs$                               | Gate-Source Charge                             | V <sub>DS</sub> =-25V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A |      | 5.3    |      | nC   |  |
| Q <sub>gd</sub>                      | Gate-Drain Charge                              |   |      | 6.4    |      | 1    |  |
| T <sub>d(on)</sub>                   | Turn-On Delay Time                             |   |      | 6      |      |      |  |
| T <sub>r</sub>                       | Rise Time                                      | V <sub>DD</sub> =-25V , V <sub>GS</sub> =-10V ,                       |      | 9      |      |      |  |
| T <sub>d(off)</sub>                  | Turn-Off Delay Time                            | $R_G=3.3\Omega$ , $I_D=-1A$   |      | 27     |      | ns   |  |
|                                      | Fall Time                                      |   |      | 48     |      |      |  |
| C <sub>iss</sub>                     | Input Capacitance                              |   |      | 1350   |      |      |  |
| Coss                                 | Output Capacitance                             | V <sub>DS</sub> =-25V , V <sub>GS</sub> =0V , f=1MHz                  |      | 180    |      | pF   |  |
| C <sub>rss</sub>                     | Reverse Transfer Capacitance                   |   |      | 85     |      |      |  |

### **Diode Characteristics**

| Symbol          | Parameter                                | Conditions  |  | Тур. | Max. | Unit |
|-----------------|--|---|--|------|------|------|
| Is              | Continuous Source Current <sup>1,6</sup> | \/ -\/ -0\/ Force Current                                       |  |      | -45  | Α    |
| I <sub>SM</sub> | Pulsed Source Current <sup>2,6</sup>     | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current              |  |      | -80  | Α    |
| V <sub>SD</sub> | Diode Forward Voltage <sup>2</sup>       | V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25℃ |  |      | -1.2 | V    |
| t <sub>rr</sub> | Reverse Recovery Time                    | IF=-12A,dI/dt=100A/µs , T <sub>.i</sub> =25℃                    |  | 31   |      | nS   |
| Q <sub>rr</sub> | Reverse Recovery Charge                  | - 12π,απαι-100π/μ3 , 1j=20 C                                    |  | 35   |      | nC   |

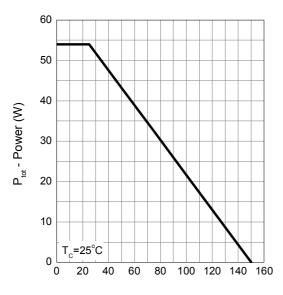
## Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width  $\leqq$  300us , duty cycle  $\leqq$  2%
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}$ =-25V, $V_{GS}$ =-10V,L=0.5mH, $I_{AS}$ =-18A
- 4.The power dissipation is limited by 150 °C junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



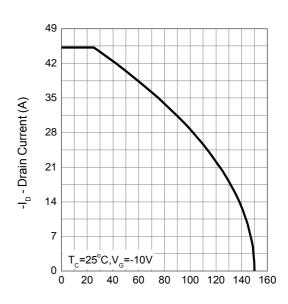
# **Typical Operating Characteristics**

# **Power Dissipation**



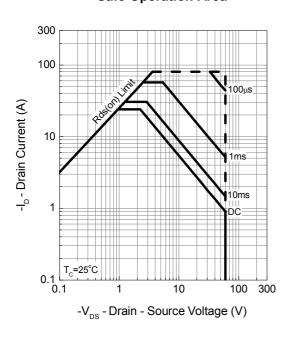
T<sub>i</sub> - Junction Temperature (°C)

#### **Drain Current**

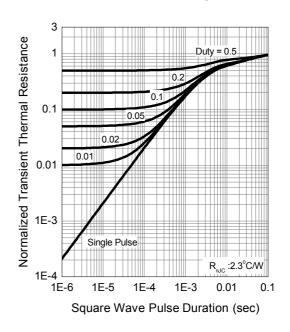


T<sub>i</sub> - Junction Temperature (°C)

### Safe Operation Area



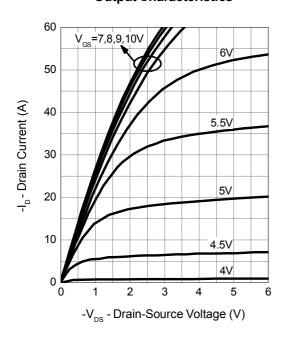
### **Thermal Transient Impedance**



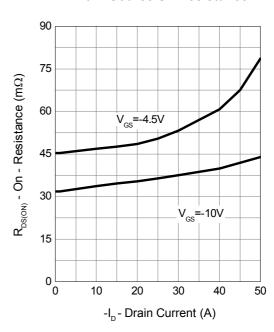


# **Typical Operating Characteristics**

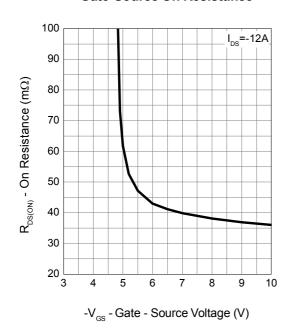
## **Output Characteristics**



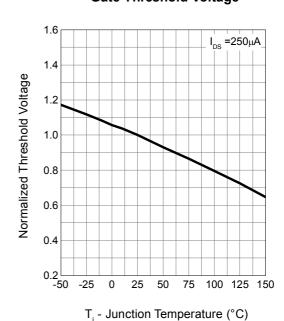
### **Drain-Source On Resistance**



### **Gate-Source On Resistance**



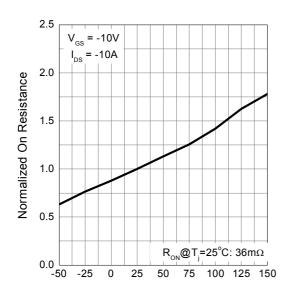
# **Gate Threshold Voltage**





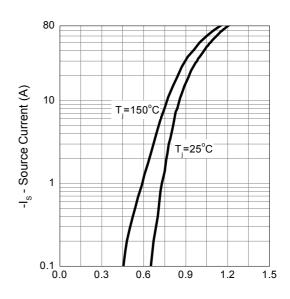
# **Typical Operating Characteristics**

### **Drain-Source On Resistance**



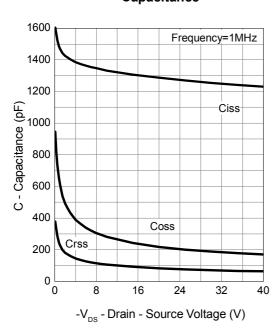
T<sub>i</sub> - Junction Temperature (°C)

### **Source-Drain Diode Forward**

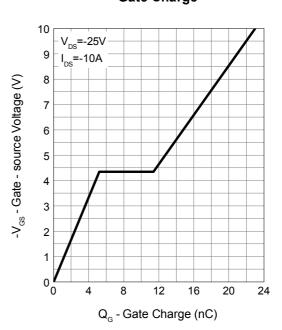


-V<sub>SD</sub> - Source - Drain Voltage (V)

## Capacitance

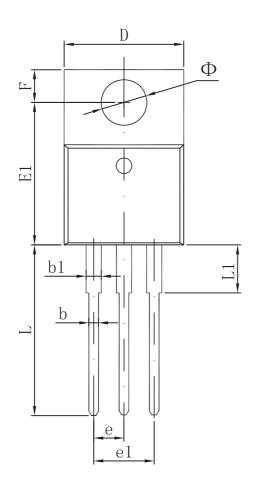


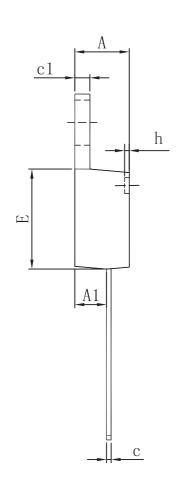
# **Gate Charge**





# **Packaging information**





| Cumbal | Dimensions In Millimeters |        | Dimensions In Inches |       |  |
|--------|---------------------------|--------|----------------------|-------|--|
| Symbol | Min                       | Max    | Min                  | Max   |  |
| A      | 4. 470                    | 4.670  | 0.176                | 0.184 |  |
| A1     | 2.520                     | 2.820  | 0.099                | 0.111 |  |
| b      | 0.710                     | 0.910  | 0.028                | 0.036 |  |
| b1     | 1.170                     | 1.370  | 0.046                | 0.054 |  |
| С      | 0.310                     | 0.530  | 0.012                | 0.021 |  |
| c1     | 1.170                     | 1.370  | 0.046                | 0.054 |  |
| D      | 10.010                    | 10.310 | 0.394                | 0.406 |  |
| Е      | 8.500                     | 8.900  | 0.335                | 0.350 |  |
| E1     | 12.060                    | 12.460 | 0.475                | 0.491 |  |
| е      | 2.540                     | ) TYP  | 0.100                | ) TYP |  |
| e1     | 4. 980                    | 5. 180 | 0.196                | 0.204 |  |
| F      | 2.590                     | 2.890  | 0.102                | 0.114 |  |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |  |
| L      | 13.400                    | 13.800 | 0.528                | 0.543 |  |
| L1     | 3.560                     | 3.960  | 0.140                | 0.156 |  |
| Ф      | 3.735                     | 3.935  | 0.147                | 0.155 |  |



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